

Notice of References Cited	Application/Control No. 10/501,165	Applicant(s)/Patent Under Reexamination ANTON APETZ ET AL.	
	Examiner Hana A. Sanei	Art Unit 2879	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,592,049	01-1997	Heider et al.	313/625
*	B	US-6,025,065	02-2000	Claussen et al.	428/307.7
*	C	US-4,766,097	08-1988	Shinozaki et al.	501/98.4
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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